APPLICANT'S ART CITATION (Use several sheets if necessary)	Application		OFC No. P/1805-17
	Applicant Markus TURTINEN et al		
	Filing Date		Group Art Unit

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
	US-					
	US-					
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	US-					

FOREIGN PATENT DOCUMENTS

	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
	10318937 A	12-1998	Japan			Abstract	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

		International Search Report for PCT/FI03/00626 dated November 7,2003
		"An Adaptive Texture and Shape Based Defect Classification" by Jukka Iivarinen et al., 1998.
		"Content-Based Image Retreival in Surface Inspection" by Jukka Iivarinen et al., 2002.
		"HIERARCHICAL Neural Network for COLOR Classification" by A. Verikas et al., 1994.

Examiner	Date Considered

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